

Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from, Europe, America and south Asia, supplying obsolete and hard-to-find components to meet their specific needs.

With the principle of "Quality Parts, Customers Priority, Honest Operation, and Considerate Service", our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip, ALPS, ROHM, Xilinx, Pulse, ON, Everlight and Freescale. Main products comprise IC, Modules, Potentiometer, IC Socket, Relay, Connector. Our parts cover such applications as commercial, industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



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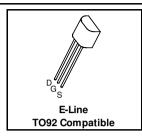
# N-CHANNEL ENHANCEMENT MODE VERTICAL DMOS FET

**ZVN2110A** 

#### ISSUE 2 - MARCH 94

**FEATURES** 

- \* 100 Volt V<sub>DS</sub>
- \*  $R_{DS(on)} = 4\Omega$



#### ABSOLUTE MAXIMUM RATINGS.

PARAMETER	SYMBOL	VALUE	UNIT
Drain-Source Voltage	V <sub>DS</sub>	100	V
Continuous Drain Current at T <sub>amb</sub> =25°C	I <sub>D</sub>	320	m A
Pulsed Drain Current	I <sub>DM</sub>	6	Α
Gate Source Voltage	V <sub>GS</sub>	± 20	V
Power Dissipation at T <sub>amb</sub> =25°C	P <sub>tot</sub>	700	mW
Operating and Storage Temperature Range	T <sub>j</sub> :T <sub>stg</sub>	-55 to +150	°C

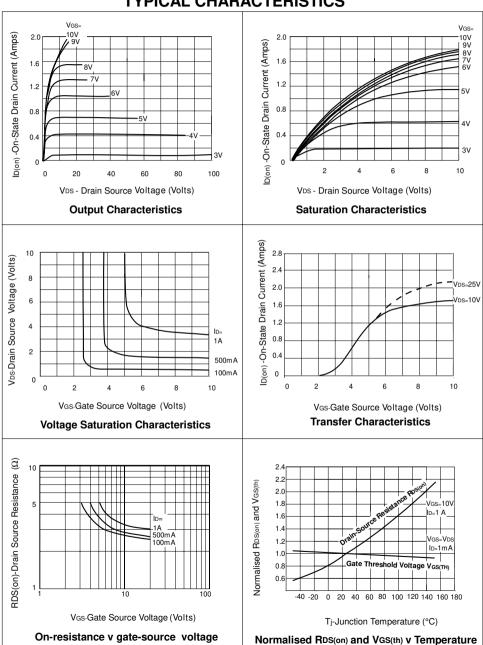
### ELECTRICAL CHARACTERISTICS (at T<sub>amb</sub> = 25°C unless otherwise stated).

PARAMETER	SYMBOL	MIN.	MAX.	UNIT	CONDITIONS.	
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	100		V	$I_D=1mA$ , $V_{GS}=0V$	
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	0.8	2.4	V	$ID=1mA$ , $V_{DS}=V_{GS}$	
Gate-Body Leakage	I <sub>GSS</sub>		20	nA	V <sub>GS</sub> =± 20V, V <sub>DS</sub> =0V	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>		1 100	μ <b>Α</b> μ <b>Α</b>	V <sub>DS</sub> =100V, V <sub>GS</sub> =0 V <sub>DS</sub> =80V, V <sub>GS</sub> =0V, T=125°C(2)	
On-State Drain Current(1)	I <sub>D(on)</sub>	1.5		Α	V <sub>DS</sub> =25V, V <sub>GS</sub> =10V	
Static Drain-Source On-State Resistance (1)	R <sub>DS(on)</sub>		4	Ω	$V_{GS}=10V,I_D=1A$	
Forward Transconductance (1)(2)	g <sub>fs</sub>	250		m S	$V_{DS}=25V,I_{D}=1A$	
Input Capacitance (2)	C <sub>iss</sub>		75	pF	V <sub>DS</sub> =25 V, V <sub>GS</sub> =0V, f=1MHz	
Common Source Output Capacitance (2)	Coss		25	pF		
Reverse Transfer Capacitance (2)	C <sub>rss</sub>		8	pF		
Turn-On Delay Time (2)(3)	t <sub>d(on)</sub>		7	ns	V <sub>DD</sub> ≈25V, I <sub>D</sub> =1A	
Rise Time (2)(3)	t <sub>r</sub>		8	ns		
Turn-Off Delay Time (2)(3)	t <sub>d(off)</sub>		13	ns		
Fall Time (2)(3)	t <sub>f</sub>		13	ns		

- (1) Measured under pulsed conditions. Width=300µs. Duty cycle ≤2%
- (2) Sample test
- (3) Switching times measured with  $50\Omega$  source impedance and <5ns rise time on a pulse generator

## **ZVN2110A**

#### **TYPICAL CHARACTERISTICS**



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## TYPICAL CHARACTERISTICS

